


<b>Search Notes</b>  	<b>Application/Control No.</b>  10541411	<b>Applicant(s)/Patent Under Reexamination</b>  ETOH, TAKEHARU
	<b>Examiner</b>  Le, Que T	<b>Art Unit</b>  2878

SEARCHED			
Class	Subclass	Date	Examiner
250	208.1, 214R, 214.1, 239, 216	10/10/07	lq
257	291-293, 440, 80-85		
348	294, 302, 314, 299		

SEARCH NOTES		
Search Notes	Date	Examiner
East search (attached)	10/10/07	lq

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
250	208.1, 214R; US-PGPUB; USPAT; Interference search (attached)	10/10/07	lq